



**UNIVERSITI TUN HUSSEIN ONN MALAYSIA**

**FINAL EXAMINATION  
SEMESTER I  
SESSION 2022/2023**

COURSE NAME : MICROFABRICATION

COURSE CODE : BEJ 43203

PROGRAMME CODE : BEJ

EXAMINATION DATE : FEBRUARY 2023

DURATION : 3 HOURS

INSTRUCTION : 1. ANSWER ALL QUESTIONS

2. THIS FINAL EXAMINATION IS CONDUCTED VIA **CLOSED BOOK**.

3. STUDENTS ARE **PROHIBITED** TO CONSULT THEIR OWN MATERIAL OR ANY EXTERNAL RESOURCES DURING THE EXAMINATION CONDUCTED VIA CLOSED BOOK.

THIS QUESTION PAPER CONSISTS OF **FOUR (4)** PAGES

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- Q1** (a) (i) Define *photolithography*. (2 marks)
- (ii) Photolithography is a center element of the wafer fabrication process. As a research student list **FIVE (5)** basic steps of the lithography process. (5 marks)
- (b) (i) Identify **TWO (2)** types of photoresist used in photolithography process. State the differences between these two types of photoresists and summarize in table. (5 marks)
- (ii) As a student, you received a task to fabricate a pattern shown in **Figure Q1(b)(ii)**. Design a suitable mask by using one of the photoresists in part **Q1(b)(i)**. (6 marks)
- (iii) Discuss the reason for your mask design in **Q1(b)(ii)**. (3 marks)
- (c) Analyse **TWO (2)** parameters that affect the thickness during photolithography process. (4 marks)
- Q2** (a) Diffusion is a process where an exact amount of impurities/dopant atoms is introduced into the semiconductor (Si) material under specific process conditions.
- (i) Analyse **TWO (2)** atomic diffusion mechanism in a two-dimensional lattice and explain clearly using appropriate diagram. (8 marks)
- (ii) Explain **TWO (2)** types of boundary conditions for diffusion process with the aid of schematic diagram. (8 marks)
- (iii) Analyse **TWO (2)** factors that influence diffusion. (4 marks)
- (b) (i) Other than diffusion, give **ONE (1)** technique to execute the doping process. (2 marks)
- (ii) As a research student, examine **THREE (3)** methods that can minimize the ion channeling effect. (3 marks)

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- Q3**
- (a) (i) Briefly explain etching process. (3 marks)
- (ii) Identify and explain **TWO (2)** kind of etching processes. (4 marks)
- (iii) Analyse the differences between wet and dry etching. (4 marks)
- (b) For a  $0.25\ \mu\text{m}$  IC chip, the polysilicon film thickness before etch process is  $3000\ \text{\AA}$  and after etching process, the thickness reduces to  $2789\ \text{\AA}$ . Calculate the etch rate for polysilicon film if time taken to etch it about 30 sec. (7 marks)
- (c) Zinc Oxide (ZnO) was deposited on Si wafer. Calculate the selectivity if the etching rate of CuO and Si is  $600\ \text{\AA}/\text{min}$  and  $30\ \text{\AA}/\text{min}$ , respectively. (7 marks)
- Q4**
- (a) As your project task, you need to deposit Aluminium (Al) electrode on Si device. You need to consider several steps below:
- (i) Propose an appropriate technique to deposit Aluminium. (3 marks)
- (ii) Explain step-by-step of the process flow with the aid of apparatus diagram. (6 marks)
- (iii) Analyse **TWO (2)** advantages of the selected method in **Q4(a)(i)** compared with the other techniques. (6 marks)
- (b) As a researcher, you need to measure the thickness of Silicon dioxide film.
- (i) Propose **TWO (2)** methods to measure the thickness. (4 marks)
- (i) Analyse which one in part **Q4(b)(i)** used optical concept and briefly explain about the method properties. (6 marks)

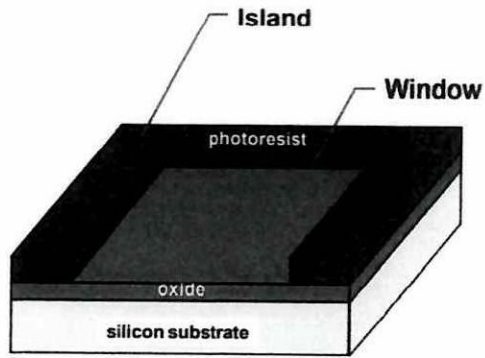
- END OF QUESTIONS -

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**Figure Q1(b)(ii)**

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